

# EE Formula Sheet

## Constants

$$\begin{aligned}q &= 1.602 \times 10^{-19} \text{ C} \\m_e &= 9.109 \times 10^{-31} \text{ kg} \\h &= 6.626 \times 10^{-34} \text{ J} \cdot \text{s} \\k &= 1.381 \times 10^{-23} \text{ J/K} \\\epsilon_0 &= 8.854 \times 10^{-12} \text{ C}^2/(\text{N} \cdot \text{m}^2) \\c &= 3.00 \times 10^8 \text{ m/s} \\e &\approx 1.6 \times 10^{-19} \text{ C} \\kT &\approx 0.026 \text{ eV at } T = 300 \text{ K}\end{aligned}$$

## Formulae

$$\begin{aligned}kT_{temp} &= 0.026 \left( \frac{temp}{300} \right), \text{ kT at a temperature temp} \\\sigma &= en\mu_n + ep\mu_p, \text{ Conduction} \\n_i^2 &= n_0 p_0, \text{ concentration at equilibrium} \\n_i^2 &= n_c n_v e^{-E_g/kT}, \\n_i^2 &\propto T^3 e^{-E_g/kT}, \text{ proportionality ratio} \\n_i^2 \text{ at } 500 &= \left( \frac{500}{300} \right)^3 e^{-E_g/kT \text{ at } 500} e^{E_g/kT \text{ at } 300}, \text{ proportional temp} \\E &= \frac{hc}{\lambda}, \text{ energy of photon} \\E_g &= E_c - E_v, \text{ Energy band gap} \\f(E) &= \frac{1}{1 + e^{\frac{E - E_f}{kT}}}, \text{ Fermi-Dirac Distribution Function} \\n &= N_c \cdot e^{-\frac{E_c - E_f}{kT}}, \text{ Electron carrier concentration} \\p &= N_v \cdot e^{-\frac{E_f - E_v}{kT}}, \text{ Hole carrier concentration} \\J_d &= q \cdot n \cdot \mu_n \cdot E, \text{ Drift Current} \\J_n &= q \cdot D_n \cdot \frac{dn}{dx}, \text{ Diffusion Current} \\E_g &= E_c - E_v, \text{ Energy-Band Gap (Eg)} \\\frac{1}{m^*} &= \frac{1}{m_l} + \frac{1}{m_t}, \text{ Electron and Hole Effective Mass} \\q &= 1.602 \times 10^{-19} \text{ C}, \text{ Charge of an Electron} \\n &= N_c \cdot e^{-\frac{E_c - E_f}{kT}}, \text{ Electron Carrier Concentration} \\p &= N_v \cdot e^{-\frac{E_f - E_v}{kT}}, \text{ Hole Carrier Concentration} \\J_n &= q \cdot n \cdot \mu_n \cdot E, \text{ Drift Current Density for Electrons} \\J_p &= q \cdot p \cdot \mu_p \cdot E, \text{ Drift Current Density for Holes} \\J_n &= q \cdot D_n \cdot \frac{dn}{dx}, \text{ Diffusion Current Density for Electrons} \\J_p &= q \cdot D_p \cdot \frac{dp}{dx}, \text{ Diffusion Current Density for Holes} \\N_c &= 2 \left( \frac{2\pi m_e kT}{h^2} \right)^{3/2}, \text{ Density of States in the Conduction Band (Nc)} \\N_v &= 2 \left( \frac{2\pi m_h kT}{h^2} \right)^{3/2}, \text{ Density of States in the Valence Band (Nv)} \\P_0 &= n_i e^{\frac{E_{fi} - E_f}{kT}} \\P_0 &= \frac{N_A - N_D}{2} + \sqrt{\left( \frac{N_A - N_D}{2} \right)^2 + n_i^2} \\N_0 &= \frac{N_D - N_A}{2} + \sqrt{\left( \frac{N_D - N_A}{2} \right)^2 + n_i^2} \\f_F(E) &= \frac{1}{1 + e^{\frac{E - E_f}{kT}}}, \text{ Fermi-Dirac Distribution Function}\end{aligned}$$

$$\begin{aligned}f_F(E) &= e^{\frac{-(E - E_f)}{kT}}, \text{ Boltzman Approximation when } E - E_f \gg kT \\\mu_n &= \frac{q \cdot \tau_n}{m^*}, \text{ Electron Mobility} \\\mu_p &= \frac{q \cdot \tau_p}{m^*}, \text{ Hole Mobility} \\G &= \alpha \cdot I, \text{ Generation Rate of Electron-Hole Pairs} \\R &= B \cdot np - A \cdot n_i^2, \text{ Recombination Rate} \\\frac{\partial n}{\partial t} + \nabla \cdot \mathbf{J}_n &= G - R, \text{ Continuity Equation for Electron Current} \\\frac{\partial p}{\partial t} - \nabla \cdot \mathbf{J}_p &= G - R, \text{ Continuity Equation for Hole Current} \\P_0 + N_D &= n_0 + N_A, \text{ Charge neutrality} \\J_{drf} &= en\mu_n E + ep\mu_p E = \sigma E, \text{ Total Drift} \\I &= A J_{drf}, \text{ Current} \\E &= \text{Volt/Len}, \text{ Electric Field} \\V_{dn} &= \mu_n E, \text{ Drift velocity for electrons} \\V_{dp} &= \mu_p E, \text{ Drift velocity for holes}\end{aligned}$$

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$$\begin{aligned}A_v &= \frac{V_{out}}{V_{in}}, \text{ Voltage Gain Formula} \\|A_v| &= g_m R_D, \\A_v &= \frac{R_D}{1/g_m}, \\V_{ov} &= V_{bias} - V_{th}, \text{ Overdrive Voltage} \\g_m &= K'_n \frac{W}{L} V_{ov}, \text{ transconductance parameter} \\g_m &= \frac{2I_D}{V_{ov}} \\I_D &= \frac{1}{2} g_m V_{ov}, \text{ Drain Current Equation} \\I_D &= \frac{1}{2} K'_n \frac{W}{L} V_{ov}^2, \text{ Drain Current Equation} \\I_D &= g_m \cdot V_{gs}, \text{ Drain current} \\I_D &= \frac{V_{DD}}{R_D}, \text{ Drain current} \\g_m &= \frac{\Delta I_D}{\Delta V_{GS}} = K'_n \frac{W}{L} V_{ov}, \\V_{DD} &= V_{DS} + I_D \cdot R_D, \text{ Load line equation} \\V_{DD} &= V_{DS} + I_D \cdot R_D, \text{ Load line equation} \\r_o &= \frac{V_A}{I_D}, \text{ Early voltage } V_A \\V'_A &= \frac{V_A}{L}, \text{ early voltage process parameter} = 20 \text{ V}/\mu\text{m} \\A_o &= g_m \cdot r_o, \text{ Intrinsic gain for bjt and mosfet} \\A_o &= \frac{2V_A}{V_{ov}}, \text{ Intrinsic gain} \\A_o &= \frac{2V'_A L}{V_{ov}}, \text{ Intrinsic gain}\end{aligned}$$

## Proportionalities

$$I_D \propto V_{ov}^2, \text{ drain current and overdrive voltage proportionality}$$

## §1.2 - The PN Junction

### Notes

**Common Source:** Input connected to gate, output connected to drain.

**Common Drain (Source Follower):** Input connected to gate, output connected to source.

**Common Gate:** Input connected to source, output connected to drain.

When  $N_A \gg N_D$ , the semiconductor is p-type.

When  $N_D \gg N_A$ , the semiconductor is n-type.

## BJT Amplifier

$$g_m = 2\sqrt{K_n I_{DQ}},$$

$$\begin{aligned}g_m &= \frac{I_D}{V_{GS}}, \\g_m &= 2K_n (V_{GS} - V_{TH}), \\g_m &= \frac{I_C}{V_{TH}}, \\g_m &= \frac{I_C}{V_T}, \\r_o &= \frac{1}{\lambda I_{DQ}}, \\r_o &= \frac{V_A}{I_C}, \\r_\pi &= \frac{V_T}{I_B}, \\r_\pi &= \frac{\beta}{g_m}, \\A_v &= -g_m \cdot R_C || R_L, \text{ Voltage Gain Formula}\end{aligned}$$

## Transistor DC Equivalent

$$\begin{aligned}V_{th} &= \frac{V_{cc}}{R_1 + R_2} \cdot R_2, \\R_{th} &= R_1 || R_2, \\V_{ce}(sat) &\approx 0.2(typ), \\I_E &\approx I_C, \text{ In active region} \\-\frac{1}{R_E - R_C}, &\text{ load line slope, where } R_C \text{ \& } R_E \text{ are from the AC or DC equivalent circuit. A load line plot is } I_C \text{ vs } V_{CE} \\I_{RE} &= I_B(\beta + 1)R_E,\end{aligned}$$

## Transistor formulas

$$\begin{aligned}I_C &= \beta \cdot I_B, \text{ Conduction Parameter} \\I_C &= I_S e^{\frac{V_{BE}}{V_T}}, \\I_B &= \frac{I_E}{\beta + 1}, \\\alpha &= \frac{I_C}{I_E}, \text{ Current Ratio} \\I_C &= I_E - I_B, \text{ Kirchhoff's Current Law} \\V_{CE} &= V_{BE} + V_{CB}, \text{ Voltage Relationships} \\I_C &= I_{C0} \left( e^{\frac{V_{BE}}{V_T}} - 1 \right), \text{ BJT Current Equation} \\I &= I_0 \cdot \left( e^{\frac{V}{n \cdot V_T}} - 1 \right), \text{ Schottky Diode Equation} \\I_D &= \frac{1}{2} \mu_n C_{ox} \frac{W}{L} (V_{GS} - V_{TH})^2, \text{ MOSFET Drain Current Equation} \\I_D &= \mu_n C_{ox} \frac{W}{L} \left[ (V_{GS} - V_{TH}) V_{DS} - \frac{V_{DS}^2}{2} \right], \text{ MOSFET Drain Current Equation (Triode Region)} \\g_m &= \sqrt{2\mu_n C_{ox} \frac{W}{L} I_D}, \text{ Transconductance Parameter} \\A_v &= -g_m \cdot R_D, \text{ Voltage Gain Formula}\end{aligned}$$

## MOS Field-Effect Transistor

### N-Channel

$v_{DS}(sat) = v_{GS} - V_{TN}$ , Saturation Voltage, where  $V_{TN}$  is the threshold voltage.

$i_D = K_n [2(v_{GS} - V_{TN})v_{DS} - v_{DS}^2]$ , I-V Characteristic in non-saturation.

$i_D = K_n (v_{GS} - V_{TN})^2$ , I-V Characteristic in saturation.

$C_{ox} = \epsilon_{ox}/t_{ox}$ , Oxide capacitance per unit area.

$\epsilon_{ox} = (3.9)(8.85 \times 10^{-14} \text{ F/cm})$ , Oxide permittivity for Si devices.

$K_n = \frac{W\mu_n C_{ox}}{2L}$ , Conduction Parameter

$K_n = \frac{k'_n}{2} \cdot \frac{W}{L}$ , Conduction Parameter

$k'_n = \mu_n C_{ox}$ , Process conduction parameter.

